Degradation modeling under multiple faiture modes

This is a statistical method.

1. Model Framework

1) Modeling health index: $Y_{LK}(t) = \psi(\chi_{LK}(t)) W_{K} - \alpha$ fusion model $Y_{LK}(t)$: HI of unit L at time t under failure mode K fact): the vector of sensor signeds $\chi_{LK}(t) = [\chi_{LL}(t), ..., \chi_{LK}(t)] \in \mathbb{R}^{|K|}$ $\psi(t)$: α basis function, e.g. linear, kernel, etc. W_{K} : fusion coefficient under failure mode K, $W_{K} \in \mathbb{R}^{m \times 1}$

Modeling degradation status: $g_{ekt} = \phi(t) T_{ek}$ $g_{lk(t)}$: degradation status of unit 1 at time to under failure mode k $g_{lk(t)}$: basis function in terms of time t, e.g, quadratic $\phi(t)=[1,t,t^{\perp}]$, p=3 $\phi(t)$: basis function in terms of $\phi(t)$: $\phi(t$

Failure mode. $Z_k \sim Multinomial(Z_1, ..., Z_k)$ Degradation parameter. $\forall l$, $\Gamma_{lk} \equiv \Gamma_{l} \mid Z_{l} = k \sim N(u_k, Z_k)$, $k \neq l, ..., K$ Noise term: $Q_{lk}(t) \equiv Q_{l}(t) \mid Z_{l} = k \sim N(0, T_k^2)$

3) The relationship between HI and degradation status $y_{kk(t)} = \psi(\chi_{k(t)}) W_{k} = g_{kk(t)} + g_{kk(t)}$ $= \phi(t) \Gamma_{k} + g_{k(t)}$

2. Parameter Estimation

Metrix form: $y_{k} = y(x_{\ell})w_{k} = \Phi_{\ell} \Gamma_{\ell k} + \xi_{\ell k}$ Historical units: sensor signals until failure.

(totally no time pomes)

(known data) failure time tre Note: 9 the failure modes of historical units are unknown 2) The failure threshold Dx is unknown, but we set arbitrary value of Dx, e.g. Dx = 1 Em Algorithm: Complete data likelihood: (24,2,1)=p(y|r,z)p(z)p(z) $=\frac{\angle}{\prod_{l=1}^{N}}p(y_{l}|\Gamma_{l},Z_{l})p(\Gamma_{l}|Z_{l})p(Z_{l})$ Define: $f_{lk} = \begin{cases} 1 & \text{if } Z_{l} = k \\ 0 & \text{if } Z_{l} \neq k \end{cases}$ $P(Z_k): P(Z_k; Z) = \frac{k}{11} (Z_k) C_{k}$ $\frac{|(21)^{1/2}}{|(12|2)|} = \frac{|(12|2)|}{|(12|2)|} =$

 $P(y_{k}|T_{k},T_{k}), P(y_{k}|T_{k},T_{k}), \sigma_{k}^{2}) = \frac{K}{11} \left(2\pi \sigma_{k}^{2} \right)^{-\frac{NL}{2}} exp \left\{ -\frac{1}{2\sigma_{k}^{2}} (y_{k} - \varphi_{k}T_{k})^{T} (y_{k} - \varphi_{k}T_{k}) \right\}$

Parameters to be estimated: (+) = ZI, TI are also unknown. (1) cannot be estimated directly. Therefore, EM algorithm is used, where ZI, TI are taken as latent variables. Estep: Given XI, and WK, ZK, UK, ZK, TK at last iteration. Then we have $y_l = \psi(\chi l) w_R$. We calculate the posterior distribution of [Ze] and Tl. $P(Z_l=k|y_l) = \frac{P(y_l|Z_l=k)P(Z_l=k)}{\sum_{k\neq l}P(y_l|Z_l=k)P(Z_l=k)}$ here: Plzp=k) = Zk ye zek ~ ~ (felk, felkfet tolt) Thus: ||f|| = ||f|| || $\frac{P(T_{\lambda}|Z_{\lambda}=k,Y_{\lambda})}{\sum_{k=1}^{K}P(Y_{\lambda}|T_{\lambda},Z_{\lambda}=k)P(T_{\lambda}|Z_{\lambda}=k)}$

 $Y_{1k} = \overline{Y}_{1} T_{1k} + \overline{Y}_{2k}$ $\sim N_{3}(\mu_{K}, \overline{Z}_{1e}) \qquad N(0, \overline{Q}^{2}) \qquad 3x3$ $Some \quad prob: \qquad 1x3 \quad 3x1 \quad (x3 \uparrow 3x1)$ $Y_{1}(t) | Z_{1} = k \quad N(\overline{Q}_{1}(t) \cdot M_{K}, \overline{Q}_{1}(t) + G_{K}^{2})$ $P(X|X_{1} = k) = \prod_{k=1}^{n} P(Y_{1}(t)|Z_{1} = k)$

Yu | Tu, Zu=K -N (DITUK+ 62 Z)

here:
$$P(T_{k} \mid \tilde{z}_{k} = b) \cdot \tilde{f}_{k} = T_{k} \mid \tilde{z}_{k} = k \times N(N_{k}, \tilde{z}_{k})$$
 $P(Y_{k} \mid T_{k}, \tilde{z}_{k} + b) \cdot \tilde{f}_{k} = T_{k} \cdot \tilde{f}_{k} + \tilde{f}_{k} \cdot \tilde{f}_{k} + \tilde{f}_{k} \cdot \tilde$

== \frac{\frac{1}{2}(\frac{1}{2})\frac{1}{2}(-\frac{1}{2})}{2}

lo update WK: At first, we regard WK as known, and obtain the estimate of Te under failure mode k from its posterior distribution. $\int_{\mathcal{M}} = \left(\int_{\mathcal{K}} \phi_{k}^{T} \phi_{k}^{T} + \sum_{k} \int_{0}^{T} \left(\int_{\mathcal{K}} \phi_{k}^{T} \psi_{k}(\chi_{k}) w_{k} + \sum_{k} u_{k} \right) \right)$ Since $\psi(x_e)_{w_k}$ is normally distributed given $z_e = k$, i.e. V(χε)ω | Ze=k ~ N(pl uk, pl Σk pl + σ2 I), ne have ler | Ze=k~N(E(Tex | Ze=k), Var (Tex | Ze=k)) $= \left(\frac{1}{\sqrt{k}} + \frac{1}{\sqrt{k}} + \frac{1}{\sqrt{k}} \right) \left(\frac{1}{\sqrt{k}} + \frac{1}{\sqrt{k}} + \frac{1}{\sqrt{k}} \right) = U_K$ $Var\left(\left|\widehat{L}_{k}\right| \neq_{\ell} = k\right) = \left(\left|\widehat{d}_{k}\right| \phi_{\ell} + \left|\widehat{d}_{\ell}\right|\right)^{-1} \left|\widehat{d}_{k} \neq_{\ell} \neq_{\ell} + \left|\widehat{d}_{\ell}\right|\right)^{-1} \left|\widehat{d}_{k} \neq_{\ell} \neq_{\ell} \neq_{\ell} + \left|\widehat{d}_{\ell}\right|\right)^{-1} \left|\widehat{d}_{k} \neq_{\ell} \neq_$ $= \left(\frac{1}{\sqrt{2}} \phi_{1} + 2 \frac{1}{\sqrt{2}} \right)^{-1} \frac{1}{\sqrt{2}} \phi_{1} \left(\frac{1}{\sqrt{2}} \phi_{1} + \sqrt{2} \frac{1}{\sqrt{2}} \right) \frac{1}{\sqrt{2}} \phi_{1} \left(\frac{1}{\sqrt{2}} \phi_{1} + \sqrt{2} \frac{1}{\sqrt{2}} \right)^{-1}$ $= \left(\frac{1}{\sqrt{2}} \phi_{1} + 2 \frac{1}{\sqrt{2}} \right)^{-1} \left(\frac{1}{\sqrt{2}} \phi_{1} + \sqrt{2} \phi_{1} \right)^{-1}$ $= \left(\frac{1}{\sqrt{2}} \phi_{1} + 2 \frac{1}{\sqrt{2}} \right)^{-1} \left(\frac{1}{\sqrt{2}} \phi_{1} + \sqrt{2} \phi_{1} + \sqrt{2}$ At failure time: We have $\phi(t_k)M_k = D_k$ according to (E_g, U) . (E_g, U) $(E_g, U$ Pristre also follows a multivariate normal distribution $E(\phi(\tau_k)) = \phi(\tau_k) E(\hat{r}_{loc}) = \phi(\tau_k) u_k = D_k$

3

 $Var(\phi LTL) \overline{\Gamma}_{ell} = \phi LTL) Var(\phi LTL) \overline{\Gamma}_{ell} = \phi \overline{\Gamma}_{ell}$ $\phi(\tau_{k})$ τ_{k} $\phi(\tau_{k})$ τ_{k} $\phi(\tau_{k})$ $\phi(\tau_{k})$ $\phi(\tau_{k})$ $\phi(\tau_{k})$ Therefore, the likelihood function

Lu = II P (P(TL) Tex | Ze = b) = (27074) - exp { 2007 (P(TL) Tex - Mx)} The log-likelihood function: $\log Lw = \sum_{\ell=1}^{J} -\frac{1}{2} \log (2\pi \sqrt{\tau_{\ell}}) - \frac{2(\tau_{\ell})}{2(\tau_{\ell})} \left(\frac{1}{(\tau_{\ell})} + \frac{1}{2} \right)^{-1} \left(\frac{1}{\tau_{\ell}} + \frac{1}{\tau_{\ell}} \right)^{-1} \left(\frac{1}{\tau_{\ell}} +$ $\widehat{W}_{k} = \underset{k=1}{\operatorname{arg min}} \underbrace{\sum \left(\widehat{\nabla}_{k} \cdot \widehat{\nabla}_{k} \cdot \widehat{\nabla}_{k} + \widehat{\nabla}_{k} \right)^{2} \left(\widehat{\nabla}_{k} \cdot \widehat{\nabla}_{k} \cdot \widehat{\nabla}_{k} + \widehat{\nabla}_{k}$ = arg min Lw $\frac{2 \ln x}{3 \pi k} = \sum_{k=1}^{N} \frac{2 \left| f(x) \right|}{\left(\int_{K^2} \varphi_k^T \varphi_k^T + \left(\int_{K^2} \varphi_k^T \varphi_k^T \varphi_k^T + \sum_{k=1}^{N} u_k \right) - D_k \right)}{\left(\int_{K^2} \varphi_k^T \varphi_k^T + \sum_{k=1}^{N} u_k \right) - D_k \right)}$ $\int_{-\infty}^{\infty} dx dx + 2x^{2} \int_{-\infty}^{\infty} dx dx$

6

Let $a = \phi(g)(\overline{\sigma_{k^2}} \phi_{\ell} \overline{\phi_{\ell}} + \overline{\mathcal{I}}_{k^{-1}})^{-1} \overline{\sigma_{k^2}} \phi_{\ell} \overline{\psi}(x_{\ell})$ $\sum_{k=1}^{2} \frac{1}{\sigma_{k}^{2}} a_{i} T \left(a_{i} w_{k} + b \left(\frac{1}{\sigma_{k}^{2}} + \frac{1}{\sigma_{k}^{2}} + \frac{1}{\sigma_{k}^{2}} \right) \sum_{k} u_{k} - D_{k} \right) = 0$ Let $b_1 = D_k - \phi(\tau_k) \left(\frac{1}{\sigma_{k^2}} + \frac{1}{\sigma_{k^2}} + \frac{1}{\sigma_{k^2}} \right)^{-1} \mathcal{I}_k \mathcal{I}_k$ $\sum_{k=1}^{\infty} \frac{1}{\sigma_{kk}^{2}} \alpha_{i}^{T} \left(\alpha_{i} w_{k} - b_{i} \right) = 0$ Lot by = ftx \(\frac{1}{5k^2} \phi_1 \frac{1}{5k^2} \phi_1 \frac{1 of 1/2 p(4) Tx let le (0/2 let let 2/) p(4) $= \psi(\mathcal{G}) \left(\frac{1}{2} + \frac{1}{2} + \frac{1}{2} \right)^{-1} + \frac{1}{2} \psi(\mathcal{G})$ J \$ (7) Zx 91 91 (5x 41 91 + 5x) \$ 770) - b1 of Dx - \$ (Tx) (of the + 3x) Ix 4x $\frac{1}{\sqrt{\sqrt{\sqrt{2}}}} = \frac{1}{\sqrt{\sqrt{\sqrt{2}}}} = \frac{1}{\sqrt{\sqrt{\sqrt{2}}}} = \frac{1}{\sqrt{\sqrt{2}}} = \frac{1}{\sqrt{2}} = \frac{1}{\sqrt$ We have $\sum_{n=1}^{\infty} a_2^{\top} a_2 w_k - a_2^{\top} b_2 = 0$ Then $\hat{W}_{K} = \left(\sum_{i=1}^{L} a_{2}^{T} a_{2}\right) \sum_{k=1}^{L} a_{2}^{T} b_{2}$

3. Failure Mode Recognition & RUL Prediction

2) RM:

Te
$$= k$$
, ye $NN\left(\left(\frac{1}{\sigma_{k^{2}}}\phi_{k} + \Sigma_{k}^{-1}\right)\left(\frac{1}{\sigma_{k^{2}}}\phi_{k} + \Sigma_{k}^{-1}\right)\left(\frac{1}{\sigma_{k^{2}}}\phi_{k} + \Sigma_{k}^{-1}\right)\right)$

Tov an in-service unit l,

$$g(t_n + t) = \phi(t_n + t) T_e$$

The probability that the degradation status exceeds the failure threshold at time t after the vis

$$F_{Te|ye} = P(T_e \leq t \mid y_e) = P(g_e(t_{ne} + t) > D \mid y_e)$$

$$= \sum_{k=1}^{K} P(g_e(t_{ne} + t) > P_k \mid y_e, z_e = k) P(z_e = k \mid y_e)$$

$$P(T_e \leq t \mid T_e \geq 0, y_e) = \frac{P(o \leq T_e \leq t \mid y_e)}{P(T_e \geq 0 \mid y_e)}$$

$$= \frac{F_{Te|ye}(t) - F_{Te|ye}(0)}{(-F_{Te|ye}(0))}$$